

oHS

N-Channel 650V (D-S) Super Junction Power MOSFET

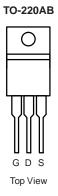
| PRODUCT SUMMARY | | | | |
|--|----------------------------|--|--|--|
| V _{DS} (V) at T _J max. | 700 | | | |
| R _{DS(on)} max. at 25 °C (Ω) | V _{GS} = 10 V 0.5 | | | |
| Q _g max. (nC) | 25 | | | |
| Q _{gs} (nC) | 2.0 | | | |
| Q _{gd} (nC) | 2.7 | | | |
| Configuration | Single | | | |

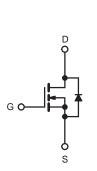
FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C | = 25 °C, unl | ess otherwis | se noted) | | | |
|---|--------------|--|-----------------------------------|-------------|----------------|-----|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 650 | V | |
| Gate-Source Voltage | | | V _{GS} | ± 30 | 1 ^v | |
| Continuous Drain Current (T _{.1} = 150 °C) | V at 10 V | V_{GS} at 10 V $T_C = 25 °C$ $T_C = 100 °C$ | | 9 | | |
| Continuous Drain Current $(1_{\rm J} = 150^{\circ}{\rm C})$ | VGS at TO V | $T_{\rm C} = 100 ^{\circ}{\rm C}$ | I _D | 6 | A | |
| Pulsed Drain Current ^a | | | I _{DM} | 21 | | |
| Linear Derating Factor | | | | 1.5 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 186 | mJ | |
| Maximum Power Dissipation | | | PD | 123 | W | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +150 | °C | |
| Drain-Source Voltage Slope $T_J = 125 \text{ °C}$ | | dV/dt | 50 | V/ns | | |
| Reverse Diode dV/dt ^d | | | | | | 4.5 |
| Soldering Recommendations (Peak Temperature) c for 10 s | | | 300 | °C | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 3.5 A.

c. 1.6 mm from case. d. $I_{SD} \le I_D$, dl/dt = 100 A/µs, starting $T_J = 25$ °C.



| THERMAL RESISTANCE RATINGS | | | | | |
|----------------------------------|-------------------|------|------|------|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | R _{thJA} | - | 63 | °C/W | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | 0.6 | 0/11 | |

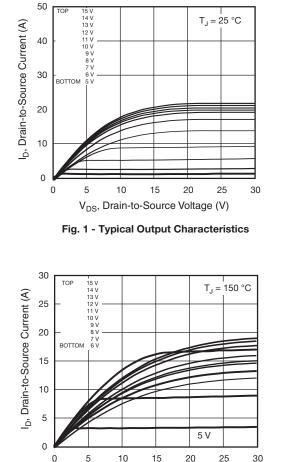
| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|---|-----------------------|---|---|------|------|----------|------|
| Static | | | | • | • | • | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} : | = 0 V, I _D = 250 μA | 650 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Referenc | e to 25 °C, I _D = 1 mA | - | 0.65 | - | V/°C |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2 | - | 4 | V |
| | | $V_{GS} = \pm 20 \text{ V}$ | | - | - | ± 100 | nA |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 30 \text{ V}$ | | - | ± 1 | μA |
| | | | = 600 V, V _{GS} = 0 V | - | - | 1 | |
| Zero Gate Voltage Drain Current | I _{DSS} | | /, V _{GS} = 0 V, T _J = 125 °C | - | - | 10 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | $I_D = 4 A$ | - | 0.50 | - | Ω |
| Forward Transconductance | g _{fs} | V _{DS} | = 30 V, I _D = 4 A | - | 16 | - | S |
| Dynamic | | • | | 1 | 1 | I | |
| Input Capacitance | C _{iss} | | V _{GS} = 0 V, | - | 360 | - | - |
| Output Capacitance | C _{oss} | | $V_{\rm GS} = 0.0$ V, $V_{\rm DS} = 100$ V, | - | 25 | - | |
| Reverse Transfer Capacitance | C _{rss} | | f = 1 MHz | | 12 | - | pF |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | V_{DS} = 0 V to 520 V, V_{GS} = 0 V | | - | 45 | - | |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | | | - | 62 | - | |
| Total Gate Charge | Qg | | | | 25 | | nC |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V I _D = 4 A, V _{DS} = 520 V | | - | 2.0 | - | |
| Gate-Drain Charge | Q _{gd} | | | - | 2.7 | - | |
| Turn-On Delay Time | t _{d(on)} | | | - | 25 | - | |
| Rise Time | t _r | Vpp | V_{DD} = 520 V, I _D = 4 A, V _{GS} = 10 V, R _g = 9.1 Ω | | 55 | - | ns |
| Turn-Off Delay Time | t _{d(off)} | 00 | | | 70 | - | |
| Fall Time | t _f | | | - | 40 | - | 1 |
| Gate Input Resistance | Rg | f = 1 MHz, open drain | | - | 3.5 | - | Ω |
| Drain-Source Body Diode Characteristic | s | - - | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 7 | |
| Pulsed Diode Forward Current | I _{SM} | | | - | - | 18 | A |
| Diode Forward Voltage | V _{SD} | T _J = 25 °C, I _S = 4 A, V _{GS} = 0 V | | - | - | 1.5 | V |
| Reverse Recovery Time | t _{rr} | $T_{J} = 25 \text{ °C}, I_{F} = I_{S} = 4 \text{ A},$ dl/dt = 100 A/µs, V _R = 400 V | | - | 190 | - | ns |
| Reverse Recovery Charge | Q _{rr} | | | - | 2.3 | - | μC |
| Reverse Recovery Current | I _{RRM} | | | | 10 | | A |

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

NCE60R540





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



V_{DS}, Drain-to-Source Voltage (V)

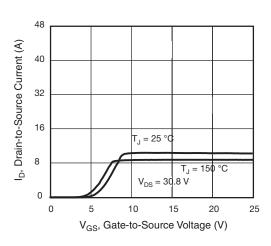


Fig. 3 - Typical Transfer Characteristics

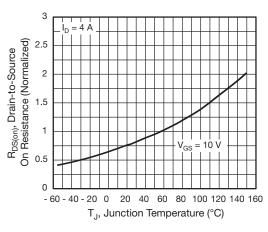


Fig. 4 - Normalized On-Resistance vs. Temperature

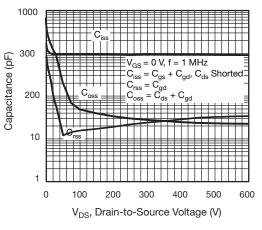


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

VBL165R09S



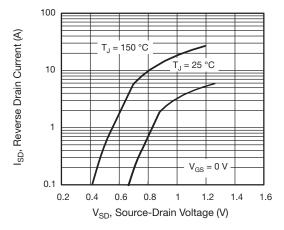


Fig. 7 - Typical Source-Drain Diode Forward Voltage

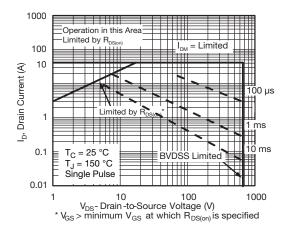


Fig. 8 - Maximum Safe Operating Area

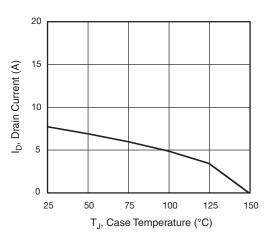


Fig. 9 - Maximum Drain Current vs. Case Temperature



Fig. 10 - Temperature vs. Drain-to-Source Voltage

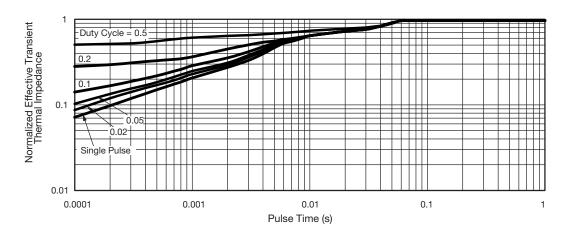


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



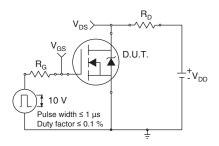


Fig. 12 - Switching Time Test Circuit

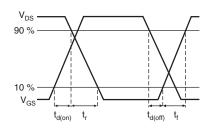


Fig. 13 - Switching Time Waveforms

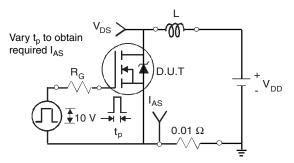


Fig. 14 - Unclamped Inductive Test Circuit

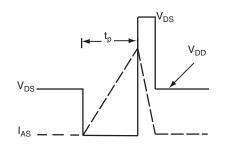


Fig. 15 - Unclamped Inductive Waveforms

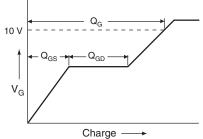


Fig. 16 - Basic Gate Charge Waveform

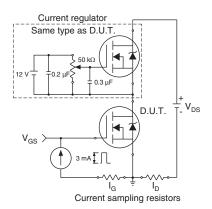
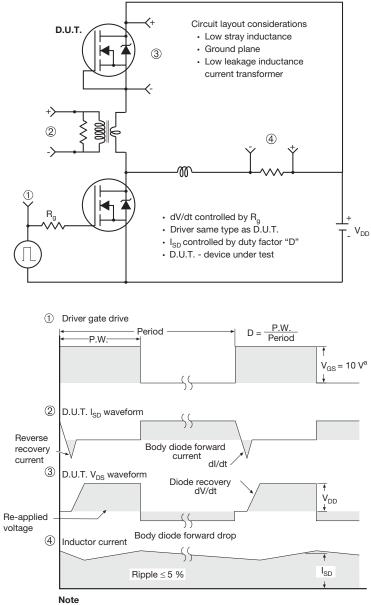


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

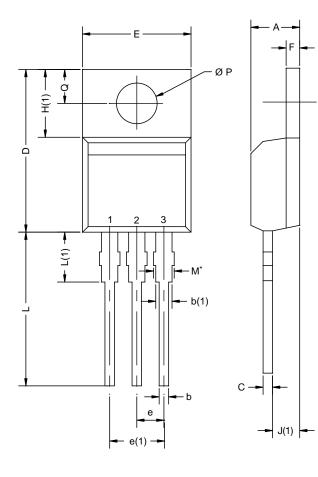


a. $V_{GS} = 5 V$ for logic level devices

Fig. 18 - For N-Channel



TO-220AB



| | MILLIN | IETERS | INCHES | | |
|--|--------|--------|--------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | |
| E | 10.04 | 10.51 | 0.395 | 0.414 | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | |
| ØΡ | 3.54 | 3.94 | 0.139 | 0.155 | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | |
| ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471 | | | | | |

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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